# 2.5V Drive Nch+SBD MOSFET **US6U37**

#### Structure

Silicon N-channel MOSFET / Schottky barrier diode

#### ● Features

- 1) Nch MOSFET and schottky barrier diode are put in TUMT6 package.
- 2) High-speed switching, Low On-resistance.
- 3) Low voltage drive (2.5V drive).
- 4) Built-in Low VF schottky barrier diode.

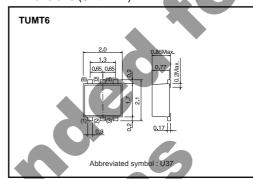
# Applications

Switching

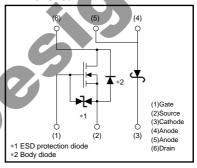
# Package specifications

|        | Package                      | Taping |  |  |
|--------|------------------------------|--------|--|--|
| Туре   | Code                         | TR     |  |  |
|        | Basic ordering unit (pieces) | 3000   |  |  |
| US6U37 |                              | 0      |  |  |

# ●Dimensions (Unit: mm)



#### Inner circuit



# ● Absolute maximum ratings (Ta=25°C)

<MOSFET>

| Parameter            |                   | Symbol             | Limits      | Unit |  |
|----------------------|-------------------|--------------------|-------------|------|--|
| Drain-source voltage |                   | V <sub>DSS</sub>   | 30          | V    |  |
| Gate-source voltage  |                   | Vgss               | ±12         | V    |  |
| Drain current        | Continuous        | lo                 | ±1.5        | Α    |  |
| Drain current        | Pulsed            | I <sub>DP</sub> *1 | ±6.0        | Α    |  |
| Source current       | Continuous        | Is                 | 0.6         | Α    |  |
| (Body diode)         | Pulsed            | I <sub>SP</sub> *1 | 6.0         | А    |  |
| Channel temperature  |                   | Tch                | 150         | °C   |  |
| Power dissipation    | P <sub>D</sub> *2 | 0.7                | W / ELEMENT |      |  |

<sup>1</sup> Pw≤10μs, Duty cycle≤1% 2 Mounted on a ceramic board

<Di>

| (DI)                            |                   |        |             |  |
|---------------------------------|-------------------|--------|-------------|--|
| Parameter                       | Symbol            | Limits | Unit        |  |
| Repetitive peak reverse voltage | V <sub>RM</sub>   | 25     | V           |  |
| Reverse voltage                 | VR                | 20     | V           |  |
| Forward current                 | lF                | 0.7    | A           |  |
| Forward current surge peak      | IFSM *1           | 10     | A           |  |
| Junction temperature            | Tj                | 150    | °C          |  |
| Power dissipation               | P <sub>D</sub> *2 | 0.5    | W / ELEMENT |  |

<sup>\*1 60</sup>Hz • 1cycle \*2 Mounted on ceramic board

# <MOSFET and Di>

| Parameter                    | Symbol            | Limits      | Unit      |  |
|------------------------------|-------------------|-------------|-----------|--|
| Power dissipation            | P <sub>D</sub> *1 | 1.0         | W / TOTAL |  |
| Range of storage temperature | Tstg              | -55 to +150 | °C        |  |

<sup>\*1</sup> Mounted on a ceramic board

# ●Electrical characteristics (Ta=25°C)

#### <MOSFET>

| Parameter                               | Symbol                 | Min. | Тур. | Max.      | Unit | Conditions                                    |
|---|------------------------|------|------|-----------|------|---|
| Gate-source leakage                     | Igss                   | _    | _    | ±10       | μΑ   | V <sub>GS</sub> =±12V, V <sub>DS</sub> =0V    |
| Drain-source breakdown voltage          | V(BR) DSS              | 30   | _    | _         | V    | ID= 1mA, VGS=0V                               |
| Zero gate voltage drain current         | IDSS                   | -    | _    | 1         | μΑ   | V <sub>DS</sub> = 30V, V <sub>GS</sub> =0V    |
| Gate threshold voltage                  | V <sub>GS (th)</sub>   | 0.5  | _    | 1.5       | V    | V <sub>DS</sub> = 10V, I <sub>D</sub> = 1mA   |
| Out to Late                             |                        | _    | 170  | 240       | mΩ   | I <sub>D</sub> = 1.5A, V <sub>G</sub> s= 4.5V |
| Static drain-source on-state resistance | R <sub>DS (on)</sub> * | ı    | 180  | 250       | mΩ   | I <sub>D</sub> = 1.5A, V <sub>G</sub> S= 4V   |
|   |                        | -    | 240  | 340       | mΩ   | ID= 1.5A, VGS= 2.5V                           |
| Forward transfer admittance             | Y <sub>fs</sub>   *    | 1.5  | _    | _         | S    | V <sub>DS</sub> = 10V, I <sub>D</sub> = 1.5A  |
| Input capacitance                       | Ciss                   | _    | 80   | _         | pF   | V <sub>DS</sub> = 10V                         |
| Output capacitance                      | Coss                   | _    | 14   | _         | pF   | V <sub>GS</sub> =0V                           |
| Reverse transfer capacitance            | Crss                   | 1    | 12   | _         | pF   | f=1MHz  |
| Turn-on delay time                      | t <sub>d (on)</sub> *  | -    | 7    | - ,       | ns   | VDD≒ 15V                                      |
| Rise time                               | tr *                   | _    | 9    |           | ns   | Ib= 0.75A<br>Vgs= 4.5V                        |
| Turn-off delay time                     | t <sub>d (off)</sub> * | _    | 15   | <b>A-</b> | ns   | $R_{L} = 20\Omega$                            |
| Fall time                               | t <sub>f</sub> *       | _    | 6    | <u> </u>  | ns   | R <sub>G</sub> =10Ω                           |
| Total gate charge                       | Qg *                   | -    | 1.6  | 2.2       | nC   | V <sub>DD</sub> ≒15V, V <sub>GS</sub> =4.5V   |
| Gate-source charge                      | Q <sub>gs</sub> *      | - /  | 0.5  | <b>—</b>  | nC   | I <sub>D</sub> = 1.5A                         |
| Gate-drain charge                       | Q <sub>gd</sub> *      | 4    | 0.3  | _         | nC   | R <sub>L</sub> =10Ω, R <sub>G</sub> =10Ω      |

\*Pulsed

# <Body diode characteristics (Source-drain)>

| Parameter       | Symbol | Min. | Тур. | Max. | Unit | Conditions                                 |
|-----------------|--------|------|------|------|------|--|
| Forward voltage | Vsp    | _    |      | 1.2  | V    | I <sub>S</sub> = 0.6A, V <sub>GS</sub> =0V |

#### ∠Di>

| -101/   |           | 7      |          |        | _    |      |                       |
|---------|-----------|--------|----------|--------|------|------|-----------------------|
|         | Parameter | Symbol | Min.     | Тур.   | Max. | Unit | Conditions            |
| Forward | d voltage | VF     | <i>F</i> | ,<br>- | 0.49 | V    | I <sub>F</sub> = 0.7A |
| Reverse | e current | IR     |          | _      | 200  | μA   | V <sub>R</sub> = 20V  |



#### Electrical characteristics curves

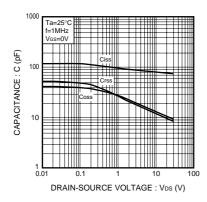


Fig.1 Typical Capacitance vs. Drain-Source Voltage

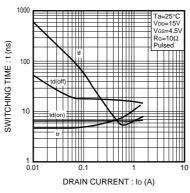


Fig.2 Switching Characteristics

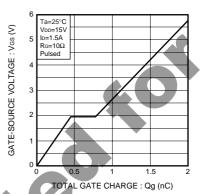


Fig.3 Dynamic Input Characteristics

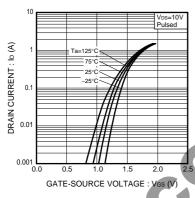


Fig.4 Typical Transfer Characteristics

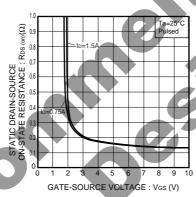


Fig.5 Static Drain-Source On-State Resistance vs. Gate source Voltage

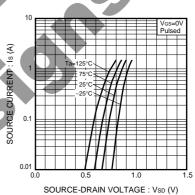


Fig.6 Source Current vs. Source-Drain Voltage

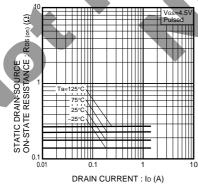


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current ( I )

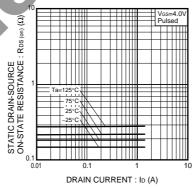


Fig.8 Static Drain-Source On-State Resistance vs. Drain Current ( II )

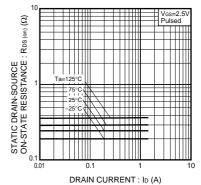
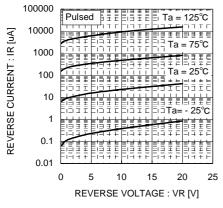


Fig.9 Static Drain-Source On-State Resistance vs. Drain Current ( III )



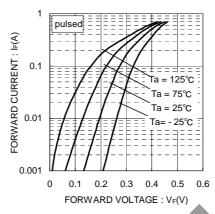


Fig.10 Reverse Current vs. Reverse

Fig.11 Forward Current vs. Forward Voltage

#### Measurement circuit

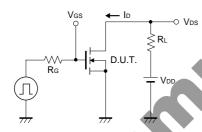


Fig.12 Switching Time Test Circuit

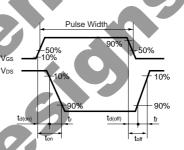


Fig.13 Switching Time Waveforms

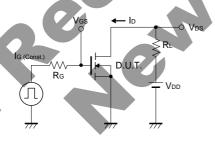


Fig.14 Gate Charge Measurement Circuit

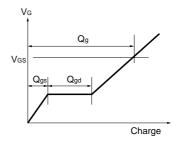


Fig.15 Gate Charge Waveform

#### ●Notice

- 1. SBD has a large reverse leak current compared to other type of diode. Therefore; it would raise a junction temperature, and increase a reverse power loss. Further rise of inside temperature would cause a thermal runaway.
  This built-in SBD has low V<sub>F</sub> characteristics and therefore, higher leak current. Please consider enough the surrounding temperature, generating heat of MOSFET and the reverse current.
- 2. This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

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